

Silicon Carbide (SiC) **MOSFET** - 31 mohm, 650 V, M2, D2PAK-7L

NTBG045N065SC1

Features

- Typ. $R_{DS(on)} = 31 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$ Typ. $R_{DS(on)} = 45 \text{ m}\Omega$ @ $V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge (Q_{G(tot)} = 105 nC)
- Low Effective Output Capacitance (Coss = 168 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

Typical Applications

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Powere Supplies)
- Energy Storages

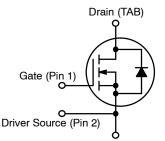
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	650	V
Gate-to-Source Voltage	ge		V_{GS}	-8/+22	V
Recommended Operation Values of Gate – Source Voltage T _C < 175°C			V_{GSop}	-5/+18	V
Continuous Drain Current (Note 2)	Steady T 0500		I _D	62	Α
Power Dissipation (Note 2)	State	T _C = 25°C	P _D	242	W
Continuous Drain Current (Notes 1, 2)	Steady	T _C = 100°C	I _D	44	Α
Power Dissipation (Notes 1, 2)	State		P _D	121	W
Pulsed Drain Current (Note 3) T _C = 25°C			I _{DM}	184	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	56	Α
Single Pulse Drain-to-Source Avalanche Energy ($I_L = 12 A_{pk}$, $L = 1 mH$) (Note 4)			E _{AS}	72	mJ
Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds			TL	245	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Surface mounted on a FR-4 board using1 in² pad of 2 oz copper.
 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature. 4. E_{AS} of 72 mJ is based on starting $T_J = 25^{\circ}C$; L = 1 mH, $I_{AS} = 12$ A, $V_{DD} = 50$ V, $V_{GS} = 18 \text{ V}.$

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
650 V	50 mΩ @ 18 V	62 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

BG045N 065SC1 **AYWWZZ**

BG045N065SC1 = Specific Device Code

= Assembly Location Α

= Lot Traceability

WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping [†]
NTBG045N065SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	0.62	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1	mA	650	-	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 20 mA, refer to 25°C		-	0.13	_	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C	_	-	10	μΑ
		V _{DS} = 650 V	T _J = 175°C	_	-	1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +18/-5 \text{ V},$	V _{DS} = 0 V	_	_	250	nA
ON CHARACTERISTICS	1	•		1			1
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D =$	8 mA	1.8	2.8	4.3	V
Recommended Gate Voltage	V_{GOP}			-5	-	+18	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 15 V, I _D =	25 A, T _J = 25°C	_	45	_	mΩ
		V _{GS} = 18 V, I _D =	25 A, T _J = 25°C	-	31	50	
		V _{GS} = 18 V, I _D = 25 A, T _J = 175°C		-	40	-	
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 25 A		-	16	-	S
CHARGES, CAPACITANCES & GATE RES	ISTANCE	•			•	•	•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 325 V		_	1890	_	pF
Output Capacitance	C _{OSS}			_	168	_	
Reverse Transfer Capacitance	C _{RSS}			_	15	_	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/18 \text{ V}, V_{DS} = 520 \text{ V},$ $I_D = 25 \text{ A}$		_	105	-	nC
Gate-to-Source Charge	Q_{GS}			_	27	-	
Gate-to-Drain Charge	Q_{GD}			-	30	_	
Gate-Resistance	R_{G}	f = 1 MHz		_	3.1	-	Ω
SWITCHING CHARACTERISTICS	1	•					ı
Turn-On Delay Time	t _{d(ON)}	V _{GS} = -5/18 V, V _{DS} = 400 V,		_	13	_	ns
Rise Time	t _r	$I_D = 25 A, R_G = 20$ Inductive Load	2.2 Ω,	_	14	_	
Turn-Off Delay Time	t _{d(OFF)}			_	26	-	1
Fall Time	t _f			_	7	-	
Turn-On Switching Loss	E _{ON}	1		_	47	-	μJ
Turn-Off Switching Loss	E _{OFF}			-	33	_	1
Total Switching Loss	E _{TOT}			-	80	_	
SOURCE-DRAIN DIODE CHARACTERIST	ics						
Continuous Source-Drain Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_J =$	25°C	-	_	56	Α
Pulsed Source-Drain Diode Forward Current (Note 3)	I _{SDM}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$		-	_	184	Α
Forward Diode Voltage	V_{SD}	$V_{GS} = -5 \text{ V}, I_{SD} = 25 \text{ A}, T_{J} = 25^{\circ}\text{C}$		_	4.4	-	V

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)(continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
SOURCE-DRAIN DIODE CHARACTERISTICS							
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/18 \text{ V, } I_{SD} = 25 \text{ A,}$ $dI_{S}/dt = 1000 \text{ A/}\mu\text{s}$	_	20	_	ns	
Reverse Recovery Charge	Q_{RR}		_	100	-	nC	
Reverse Recovery Energy	E _{REC}		_	3.8	-	μJ	
Peak Reverse Recovery Current	I _{RRM}		-	10	-	Α	
Charge Time	Ta		-	11	-	ns	
Discharge Time	Tb		-	8.7	_	ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

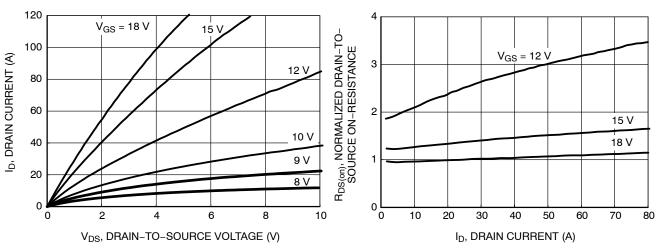


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain **Current and Gate Voltage**

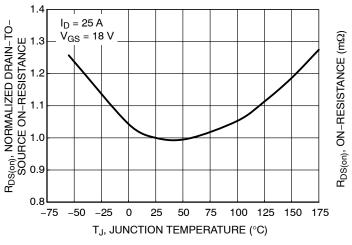


Figure 3. On-Resistance Variation with **Temperature**

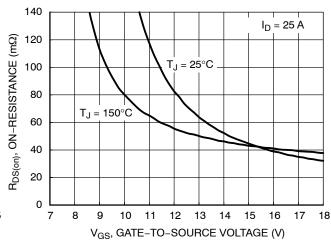


Figure 4. On-Resistance vs. Gate-to-Source Voltage

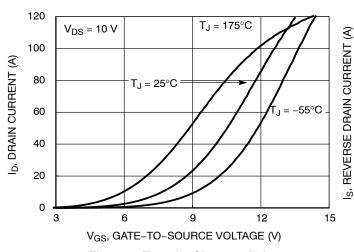


Figure 5. Transfer Characteristics

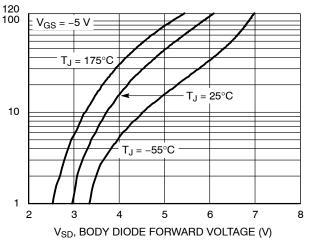


Figure 6. Diode Forward Voltage vs. Current

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TYPICAL CHARACTERISTICS (continued)

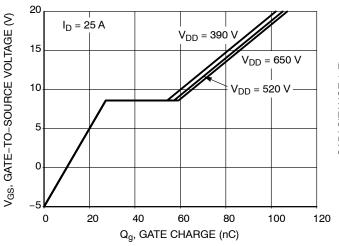


Figure 7. Gate-to-Source Voltage vs. Total Charge

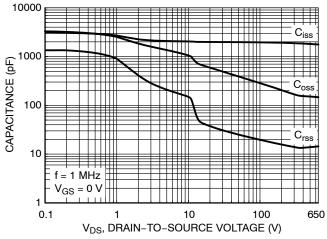


Figure 8. Capacitance vs. Drain-to-Source Voltage

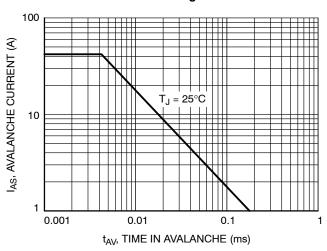


Figure 9. Unclamped Inductive Switching Capability

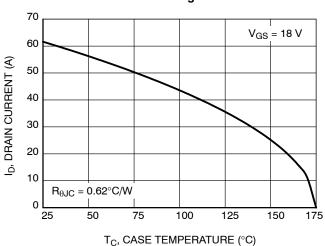


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

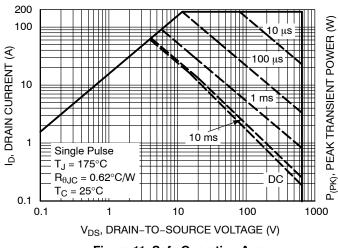


Figure 11. Safe Operating Area

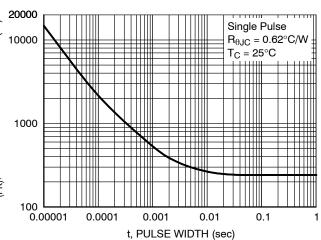


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

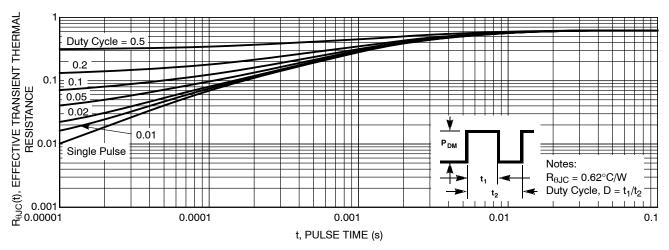


Figure 13. Junction-to-Case Transient Thermal Response

Α

D

aaa | B | A |M

3.20 MIN

E1

D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

DATE 16 AUG 2019

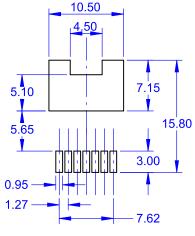
NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.

 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

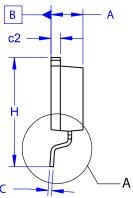
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	4.30	4.50	4.70			
A 1	0.00	0.10	0.20			
b2	0.60	0.70	0.80			
b	0.51	0.60	0.70			
С	0.40	0.50	0.60			
c2	1.20	1.30	1.40			
D	9.00	9.20	9.40			
D1	6.15	6.80	7.15			
Е	9.70	9.90	10.20			
E1	7.15	7.65	8.15			
е	~	1.27	~			
Н	15.10	15.40	15.70			
L	2.44	2.64	2.84			
L1	1.00	1.20	1.40			
L3	~	0.25	~			
aaa	~	~	0.25			



LAND PATTERN RECOMMENDATION





GENERIC MARKING DIAGRAM*

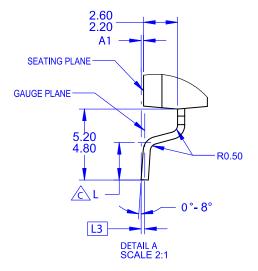
D1



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.



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DESCRIPTION:	D ² PAK7 (TO-263-7L HV)		PAGE 1 OF 1

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